



RADIO TEST REPORT

Test Report No. : 13056282H-A-R1

Applicant : DENSO CORPORATION
Type of Equipment : Electronic Key
Model No. : 14FLA
FCC ID : HYQ14FLA
Test regulation : FCC Part 15 Subpart C: 2019
Test Result : Complied (Refer to SECTION 3.2)

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
7. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
8. The information provided from the customer for this report is identified in SECTION 1.
9. This report is a revised version of 13056282H-A. 13056282H-A is replaced with this report.

Date of test: September 27 and October 1, 2019

Representative test engineer:

Hiroyuki Furutaka
Engineer
Consumer Technology Division

Approved by:

Motoya Imura
Leader
Consumer Technology Division



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REVISION HISTORY

Original Test Report No.: 13056282H-A

Revision	Test report No.	Date	Page revised	Contents
- (Original)	13056282H-A	October 8, 2019	-	-
1	13056282H-A-R1	October 15, 2019	P. 16	Change the Limit of 312.10 MHz for Radiated emission test

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Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	MCS	Modulation and Coding Scheme
AC	Alternating Current	MRA	Mutual Recognition Arrangement
AFH	Adaptive Frequency Hopping	N/A	Not Applicable
AM	Amplitude Modulation	NIST	National Institute of Standards and Technology
Amp, AMP	Amplifier	NS	No signal detect.
ANSI	American National Standards Institute	NSA	Normalized Site Attenuation
Ant, ANT	Antenna	NVLAP	National Voluntary Laboratory Accreditation Program
AP	Access Point	OBW	Occupied Band Width
ASK	Amplitude Shift Keying	OFDM	Orthogonal Frequency Division Multiplexing
Atten., ATT	Attenuator	P/M	Power meter
AV	Average	PCB	Printed Circuit Board
BPSK	Binary Phase-Shift Keying	PER	Packet Error Rate
BR	Bluetooth Basic Rate	PHY	Physical Layer
BT	Bluetooth	PK	Peak
BT LE	Bluetooth Low Energy	PN	Pseudo random Noise
BW	BandWidth	PRBS	Pseudo-Random Bit Sequence
Cal Int	Calibration Interval	PSD	Power Spectral Density
CCK	Complementary Code Keying	QAM	Quadrature Amplitude Modulation
Ch., CH	Channel	QP	Quasi-Peak
CISPR	Comite International Special des Perturbations Radioelectriques	QPSK	Quadri-Phase Shift Keying
CW	Continuous Wave	RBW	Resolution Band Width
DBPSK	Differential BPSK	RDS	Radio Data System
DC	Direct Current	RE	Radio Equipment
D-factor	Distance factor	RF	Radio Frequency
DFS	Dynamic Frequency Selection	RMS	Root Mean Square
DQPSK	Differential QPSK	RSS	Radio Standards Specifications
DSSS	Direct Sequence Spread Spectrum	Rx	Receiving
EDR	Enhanced Data Rate	SA, S/A	Spectrum Analyzer
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	SG	Signal Generator
EMC	ElectroMagnetic Compatibility	SVSWR	Site-Voltage Standing Wave Ratio
EMI	ElectroMagnetic Interference	TR	Test Receiver
EN	European Norm	Tx	Transmitting
ERP, e.r.p.	Effective Radiated Power	VBW	Video BandWidth
EU	European Union	Vert.	Vertical
EUT	Equipment Under Test	WLAN	Wireless LAN
Fac.	Factor		
FCC	Federal Communications Commission		
FHSS	Frequency Hopping Spread Spectrum		
FM	Frequency Modulation		
Freq.	Frequency		
FSK	Frequency Shift Keying		
GFSK	Gaussian Frequency-Shift Keying		
GNSS	Global Navigation Satellite System		
GPS	Global Positioning System		
Hori.	Horizontal		
ICES	Interference-Causing Equipment Standard		
IEC	International Electrotechnical Commission		
IEEE	Institute of Electrical and Electronics Engineers		
IF	Intermediate Frequency		
ILAC	International Laboratory Accreditation Conference		
ISED	Innovation, Science and Economic Development Canada		
ISO	International Organization for Standardization		
JAB	Japan Accreditation Board		
LAN	Local Area Network		
LIMS	Laboratory Information Management System		

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SECTION 1: Customer information

Company Name : DENSO CORPORATION
Address : 1-1, Showa-cho, Kariya-shi, Aichi-ken, 448-8661, Japan
Telephone Number : +81-566-20-3955
Facsimile Number : +81-566-25-4837
Contact Person : TAKAYUKI HATTORI

The information provided from the customer is as follows;

- Applicant, Type of Equipment, Model No. FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (E.U.T.)
- SECTION 4: Operation of E.U.T. during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Electronic Key
Model No. : 14FLA
Serial No. : Refer to Section 4, Clause 4.2
Rating : DC 3.0 V
Receipt Date of Sample : September 27, 2019
(Information from test lab.)
Country of Mass-production : Japan, United States of America, China
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

Model: 14FLA (referred to as the EUT in this report) is a Electronic Key.

Radio Specification

Radio Type : Transceiver
Frequency of Operation : 312.10 MHz / 314.35 MHz*
*These two different frequencies are not emitted simultaneously.
Modulation : FSK (F1D)
Type of Battery : One lithium battery
Antenna type : Built-in type (Fixed)
Clock frequency (Maximum) : 18.37 MHz Crystal

Radio Type : Receiver
Frequency of Operation : 134.2 kHz *1)

*1) The test of receiver part was performed separately from this test report, and the conformability is confirmed.

* Original model: 14FLA has two types; Type A and Type B.
The worst case was confirmed with Type A and Type B at pre check.
The test was performed with Type A, which had the worst result.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on July 19, 2019 and effective August 19, 2019 except 15.258

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.231 Periodic operation in the band 40.66-40.70 MHz and above 70 MHz.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: RSS-Gen 8.8	FCC: Section 15.207 ----- ISED: RSS-Gen 8.8	N/A	N/A	*1)
Automatically Deactivate	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: -	FCC: Section 15.231(a)(1) ----- ISED: RSS-210 A1.1	N/A	Complied a)	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: RSS-Gen 6.12	FCC: Section 15.231(b) ----- ISED: RSS-210 A1.2	3.3 dB 312.10 MHz Horizontal PK with Duty factor	Complied# b)	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: RSS-Gen 6.13	FCC: Section 15.205 Section 15.209 Section 15.231(b) ----- ISED: RSS-210 A1.2, 4.4 RSS-Gen 8.9	8.4 dB 3121.0 MHz Vertical PK with Duty factor <312.10 MHz>	Complied b)	Radiated
-20dB Bandwidth	FCC: ANSI C63.10:2013 6 Standard test methods ----- ISED: -	FCC: Section 15.231(c) ----- ISED: Reference data	N/A	Complied c)	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT does not have AC Mains.

a) Refer to APPENDIX 1 (data of Automatically deactivate)

b) Refer to APPENDIX 1 (data of Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission))

c) Refer to APPENDIX 1 (data of -20dB and 99% Occupied Bandwidth)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

FCC Part 15.31 (e)

This test was performed with the New Battery (DC 3.0 V) and the constant voltage was supplied to the EUT during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	ISED: RSS-Gen 6.7	ISED: RSS-210 A1.3	N/A	-	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the following results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Test date: Before September 30, 2019

Radiated emission

Measurement distance	Frequency range	Uncertainty (+/-)	
3 m	9 kHz to 30 MHz	3.3 dB	
10 m		3.2 dB	
3 m	30 MHz to 200 MHz	(Horizontal)	4.8 dB
		(Vertical)	5.0 dB
	200 MHz to 1000 MHz	(Horizontal)	5.2 dB
		(Vertical)	6.3 dB
10 m	30 MHz to 200 MHz	(Horizontal)	4.8 dB
		(Vertical)	4.9 dB
	200 MHz to 1000 MHz	(Horizontal)	5.0 dB
		(Vertical)	5.0 dB
3 m	1 GHz to 6 GHz	5.0 dB	
	6 GHz to 18 GHz	5.3 dB	
1 m	10 GHz to 26.5 GHz	5.8 dB	
	26.5 GHz to 40 GHz	5.8 dB	
10 m	1 GHz to 18 GHz	5.2 dB	

Antenna Terminal test

Test Item	Uncertainty (+/-)
Automatically Deactivate	0.10 %
-20dB Emission Bandwidth / 99 % Occupied Bandwidth	0.96 %

Test date: After October 1, 2019

Radiated emission

Measurement distance	Frequency range	Uncertainty (+/-)	
3 m	9 kHz to 30 MHz	3.3 dB	
10 m		3.2 dB	
3 m	30 MHz to 200 MHz	(Horizontal)	4.8 dB
		(Vertical)	5.0 dB
	200 MHz to 1000 MHz	(Horizontal)	5.2 dB
		(Vertical)	6.3 dB
10 m	30 MHz to 200 MHz	(Horizontal)	4.8 dB
		(Vertical)	4.8 dB
	200 MHz to 1000 MHz	(Horizontal)	5.0 dB
		(Vertical)	5.0 dB
3 m	1 GHz to 6 GHz	4.9 dB	
	6 GHz to 18 GHz	5.2 dB	
1 m	10 GHz to 26.5 GHz	5.5 dB	
	26.5 GHz to 40 GHz	5.5 dB	
10 m	1 GHz to 18 GHz	5.2 dB	

Antenna Terminal test

Test Item	Uncertainty (+/-)
Automatically Deactivate	0.10 %
-20dB Emission Bandwidth / 99 % Occupied Bandwidth	0.96 %

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3.5 Test Location

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*NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967 / ISED Lab Company Number: 2973C

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Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting p lane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0 m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

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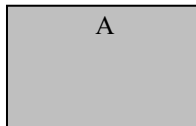
Facsimile : +81 596 24 8124

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

Test Item*	Mode
Automatically Deactivate	Normal use mode
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20 dB & 99 % Occupied Bandwidth Duty Cycle	Transmitting mode (Tx)
* The system was configured in typical fashion (as a user would normally use it) for testing. End users cannot change the settings of the output power of the product.	

4.2 Configuration and peripherals



* Setup was taken into consideration and test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Electronic Key	14FLA	001 *1) 002 *2)	DENSO CORPORATION	EUT

*1) Used for Normal use mode

*2) Used for Transmitting mode

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

[For below 30 MHz]

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

[For 30 MHz to 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

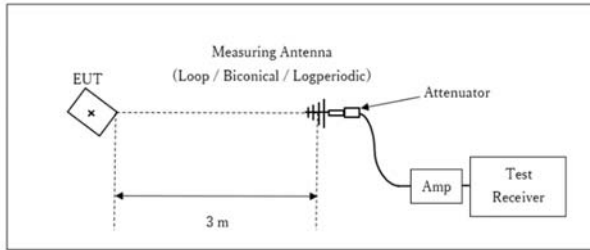
Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz	Above 1 GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200 Hz	200 Hz	9.0 kHz	9.0 kHz	120 kHz	PK: S/A: RBW 1 MHz, VBW: 3 MHz

[Test Setup]

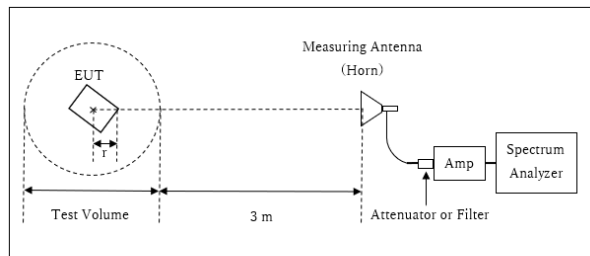
Below 1 GHz



× : Center of turn table

Test Distance: 3 m

1 GHz - 10 GHz



r : Radius of an outer periphery of EUT
 × : Center of turn table

Distance Factor: $20 \times \log(4.0 \text{ m} / 3.0 \text{ m}) = 2.50 \text{ dB}$
 * Test Distance: $(3 + \text{Test Volume} / 2) - r = 4.00 \text{ m}$

Test Volume : 2.0 m
 (Test Volume has been calibrated based on CISPR 16-1-4.)
 r = 0.0 m

* The test was performed with r = 0.0 m since EUT is small and it was the rather conservative condition.

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.
 Noise levels of all the frequencies were measured at the position.

This EUT has two modes which mechanical key is inserted or not. The worst case was confirmed with and without mechanical key, as a result, the test with mechanical key was the worst case. Therefore the test with mechanical key was performed only.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range : 9 kHz - 3.2 GHz
Test data : APPENDIX
Test result : Pass

SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX
Test result : Pass

SECTION 7: -20 dB and 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	150 kHz	1 kHz	3 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer

Peak hold was applied as Worst-case measurement.

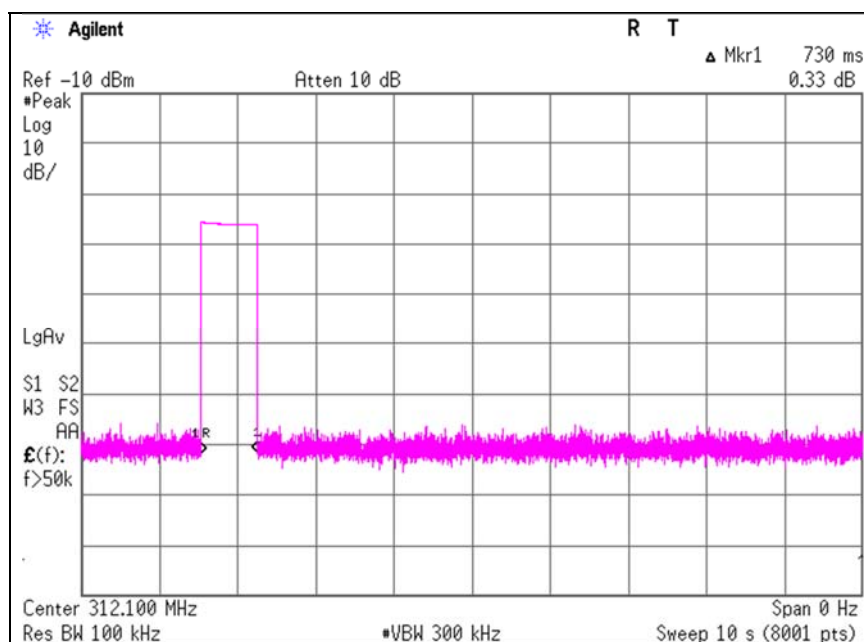
Test data : APPENDIX
Test result : Pass

APPENDIX 1: Test data

Automatically deactivate

Report No. 13056282H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date September 27, 2019
Temperature / Humidity 24 deg. C / 53 % RH
Engineer Hiroyuki Furutaka
Mode Normal use mode 312.10 MHz

Time of Transmitting [sec]	Limit [sec]	Result
0.73	5.00	Pass



* The EUT transmits UHF when LF signal is received from a car or a button on the EUT is pressed. In both cases, the UHF transmission is stopped within 5 seconds. So the test was performed by a button-pressed operation as the worst case.

Please refer to the “Theory of Operation” for details.

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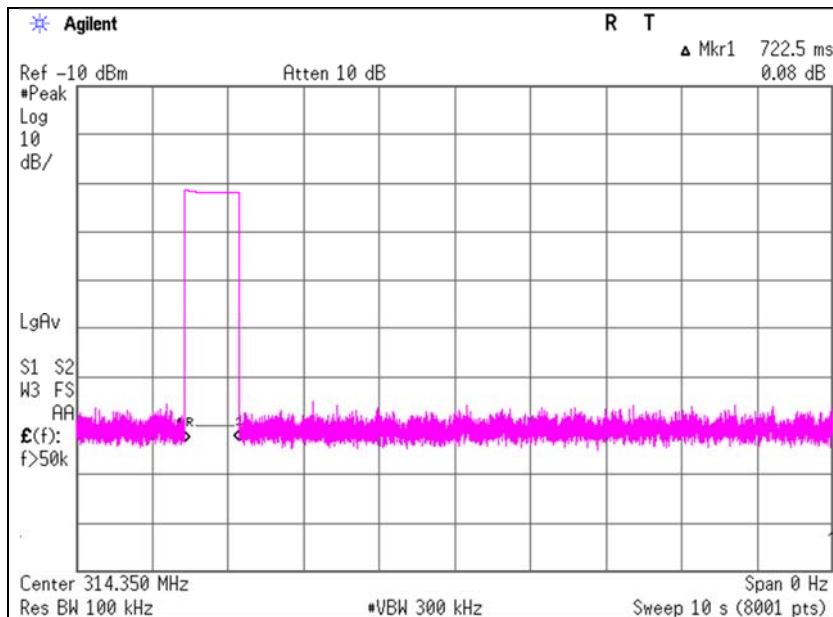
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Automatically deactivate

Report No. 13056282H
 Test place Ise EMC Lab.
 Semi Anechoic Chamber No.1
 Date September 27, 2019
 Temperature / Humidity 24 deg. C / 53 % RH
 Engineer Hiroyuki Furutaka
 Mode Normal use mode 314.35 MHz

Time of Transmitting [sec]	Limit [sec]	Result
0.7225	5.00	Pass



* The EUT transmits UHF when LF signal is received from a car or a button on the EUT is pressed. In both cases, the UHF transmission is stopped within 5 seconds. So the test was performed by a button-pressed operation as the worst case.

Please refer to the "Theory of Operation" for details.

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No.	13056282H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.3
Date	September 27, 2019	October 1, 2019
Temperature / Humidity	24 deg. C / 53 % RH	21 deg. C / 66 % RH
Engineer	Hiroyuki Furutaka	Yuichiro Yamazaki
	(Below 1GHz)	(Above 1GHz)
Mode	Transmitting mode 312.10 MHz	

QP or PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
312.100	PK	86.3	83.4	13.9	10.8	38.9	-	72.2	69.3	95.4	23.3	26.2	Carrier
624.200	PK	39.2	37.2	19.5	13.1	38.4	-	33.4	31.4	75.4	42.0	44.0	Outside
936.300	PK	32.2	32.3	21.9	14.9	38.1	-	30.9	31.0	75.4	44.5	44.4	Outside
1248.400	PK	45.0	44.8	25.3	6.1	34.8	-	41.7	41.5	75.4	33.7	34.0	Outside
1560.500	PK	43.8	44.2	25.5	5.5	34.0	-	40.8	41.2	73.9	33.1	32.7	Inside
1872.600	PK	43.5	43.3	26.2	5.5	33.2	-	42.0	41.7	75.4	33.5	33.7	Outside
2184.700	PK	44.0	43.3	28.0	5.6	32.8	-	44.7	44.1	75.4	30.7	31.3	Outside
2496.800	PK	43.6	43.5	28.6	5.7	32.7	-	45.2	45.1	73.9	28.8	28.8	Inside
2808.900	PK	42.9	43.2	28.9	5.8	32.6	-	45.0	45.3	73.9	28.9	28.6	Inside
3121.000	PK	43.5	44.2	29.4	5.9	32.4	-	46.3	47.0	75.4	29.1	28.4	Outside

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
312.100	PK	86.3	83.4	13.9	10.8	38.9	0.0	72.2	69.3	75.4	3.3	6.2	Carrier
624.200	PK	39.2	37.2	19.5	13.1	38.4	0.0	33.4	31.4	55.4	22.0	24.0	Outside
936.300	PK	32.2	32.3	21.9	14.9	38.1	0.0	30.9	31.0	55.4	24.5	24.4	Outside
1248.400	PK	45.0	44.8	25.3	6.1	34.8	0.0	41.7	41.5	55.4	13.7	14.0	Outside
1560.500	PK	43.8	44.2	25.5	5.5	34.0	0.0	40.8	41.2	53.9	13.1	12.7	Inside
1872.600	PK	43.5	43.3	26.2	5.5	33.2	0.0	42.0	41.7	55.4	13.5	13.7	Outside
2184.700	PK	44.0	43.3	28.0	5.6	32.8	0.0	44.7	44.1	55.4	10.7	11.3	Outside
2496.800	PK	43.6	43.5	28.6	5.7	32.7	0.0	45.2	45.1	53.9	8.8	8.8	Inside
2808.900	PK	42.9	43.2	28.9	5.8	32.6	0.0	45.0	45.3	53.9	8.9	8.6	Inside
3121.000	PK	43.5	44.2	29.4	5.9	32.4	0.0	46.3	47.0	55.4	9.1	8.4	Outside

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Sample calculation:

Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1GHz) + Distance factor (above 1 GHz)} - Gain (Amplifier)

Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) + Distance factor (above 1 GHz)} - Gain (Amplifier) + Duty factor

For above 1GHz : Distance Factor: $20 \times \log(4.0 \text{ m}/3.0 \text{ m}) = 2.50 \text{ dB}$

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

UL Japan, Inc.

Ise EMC Lab.

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No.	13056282H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.3
Date	September 27, 2019	October 1, 2019
Temperature / Humidity	24 deg. C / 53 % RH	21 deg. C / 66 % RH
Engineer	Hiroyuki Furutaka	Yuichiro Yamazaki
	(Below 1GHz)	(Above 1GHz)
Mode	Transmitting mode 314.35 MHz	

QP or PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
314.350	PK	85.8	82.1	14.0	10.8	38.9	-	71.8	68.1	95.5	23.7	27.4	Carrier
628.700	PK	39.9	38.2	19.5	13.1	38.4	-	34.1	32.4	75.5	41.4	43.1	Outside
943.050	PK	32.1	32.2	21.9	14.9	38.1	-	30.8	30.9	75.5	44.7	44.6	Outside
1257.400	PK	44.7	44.7	25.3	6.1	34.7	-	41.3	41.3	75.5	34.2	34.2	Outside
1571.750	PK	43.6	43.9	25.2	5.5	34.0	-	40.4	40.7	73.9	33.5	33.2	Inside
1886.100	PK	43.6	43.5	26.4	5.5	33.2	-	42.3	42.2	75.5	33.3	33.3	Outside
2200.450	PK	43.4	43.7	28.2	5.6	32.8	-	44.4	44.7	73.9	29.5	29.2	Inside
2514.800	PK	43.4	43.4	28.4	5.7	32.7	-	44.7	44.8	75.5	30.8	30.7	Outside
2829.150	PK	43.5	43.1	28.7	5.8	32.5	-	45.4	45.0	73.9	28.5	28.9	Inside
3143.500	PK	43.2	43.5	29.2	5.9	32.4	-	46.0	46.2	75.5	29.6	29.3	Outside

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
314.350	PK	85.8	82.1	14.0	10.8	38.9	0.0	71.8	68.1	75.5	3.7	7.4	Carrier
628.700	PK	39.9	38.2	19.5	13.1	38.4	0.0	34.1	32.4	55.5	21.4	23.1	Outside
943.050	PK	32.1	32.2	21.9	14.9	38.1	0.0	30.8	30.9	55.5	24.7	24.6	Outside
1257.400	PK	44.7	44.7	25.3	6.1	34.7	0.0	41.3	41.3	55.5	14.2	14.2	Outside
1571.750	PK	43.6	43.9	25.2	5.5	34.0	0.0	40.4	40.7	53.9	13.5	13.2	Inside
1886.100	PK	43.6	43.5	26.4	5.5	33.2	0.0	42.3	42.2	55.5	13.3	13.3	Outside
2200.450	PK	43.4	43.7	28.2	5.6	32.8	0.0	44.4	44.7	53.9	9.5	9.2	Inside
2514.800	PK	43.4	43.4	28.4	5.7	32.7	0.0	44.7	44.8	55.5	10.8	10.7	Outside
2829.150	PK	43.5	43.1	28.7	5.8	32.5	0.0	45.4	45.0	53.9	8.5	8.9	Inside
3143.500	PK	43.2	43.5	29.2	5.9	32.4	0.0	46.0	46.2	55.5	9.5	9.3	Outside

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Sample calculation:

Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1GHz) + Distance factor (above 1 GHz)} - Gain (Amplifier)

Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator + Filter (above 1 GHz) + Distance factor (above 1 GHz)} - Gain (Amplifier) + Duty factor

For above 1GHz : Distance Factor: $20 \times \log(4.0 \text{ m}/3.0 \text{ m}) = 2.50 \text{ dB}$

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

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Ise EMC Lab.

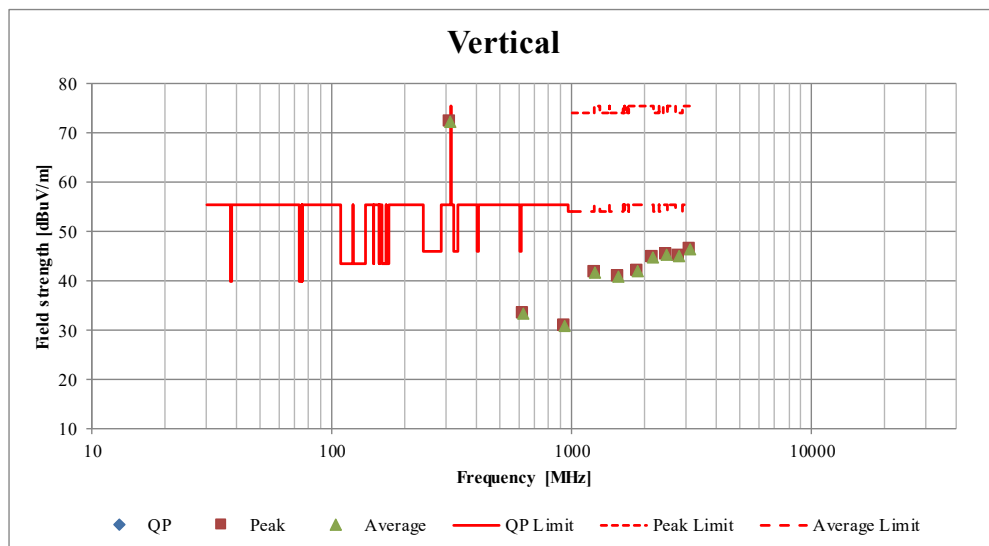
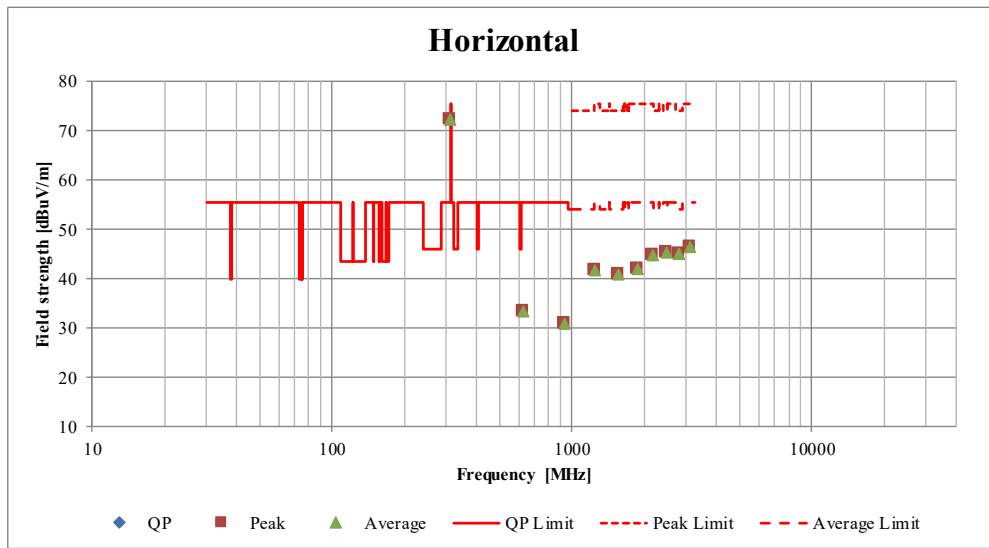
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Radiated Spurious Emission
(Plot data, Worst case)

Report No.	13056282H	
Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.1	No.3
Date	September 27, 2019	October 1, 2019
Temperature / Humidity	24 deg. C / 53 % RH	21 deg. C / 66 % RH
Engineer	Hiroyuki Furutaka (Below 1GHz)	Yuichiro Yamazaki (Above 1GHz)
Mode	Transmitting mode 312.10 MHz	



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

-20dB and 99% Occupied Bandwidth

Report No. 13056282H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date September 27, 2019
Temperature / Humidity 24 deg. C / 53 % RH
Engineer Hiroyuki Furutaka
Mode Transmitting mode 312.10 MHz / 314.35 MHz

Bandwidth Limit : Fundamental Frequency **312.10** MHz x 0.25% = 780.25 kHz

* The above limit was calculated from more stringent nominal frequency.

* Method of KDB 926416 for systems employing non sweeping frequencies was referred.

312.10MHz

-20dB Bandwidth [kHz]
36.578

314.35MHz

-20dB Bandwidth [kHz]
36.590

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
73.168	780.25	Pass

Bandwidth Limit : Fundamental Frequency **312.10** MHz x 0.25% = 780.25 kHz

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
36.0477	780.25	Pass

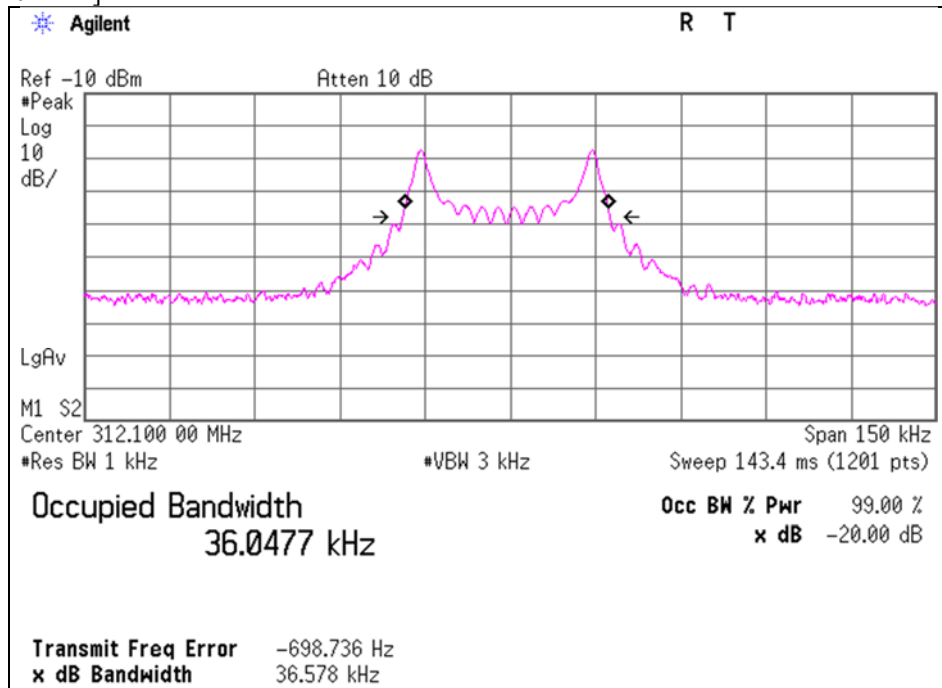
Bandwidth Limit : Fundamental Frequency **314.35** MHz x 0.25% = 785.88 kHz

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
36.1778	785.88	Pass

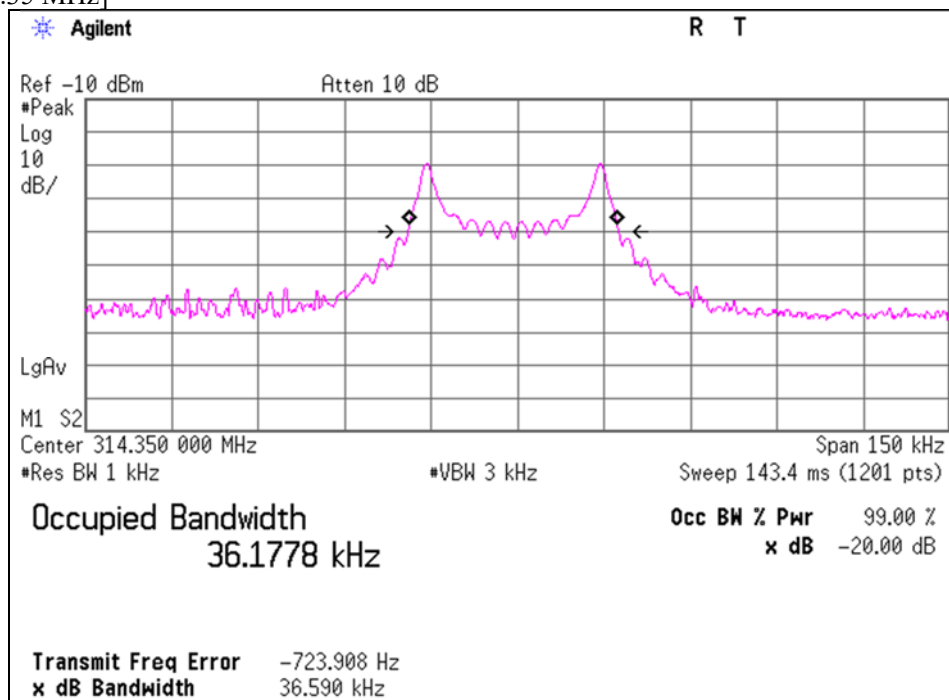
-20dB and 99% Occupied Bandwidth

Report No.	13056282H
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.1
Date	September 27, 2019
Temperature / Humidity	24 deg. C / 53 % RH
Engineer	Hiroyuki Furutaka
Mode	Transmitting mode 312.10 MHz / 314.35 MHz

[312.10 MHz]



[314.35 MHz]



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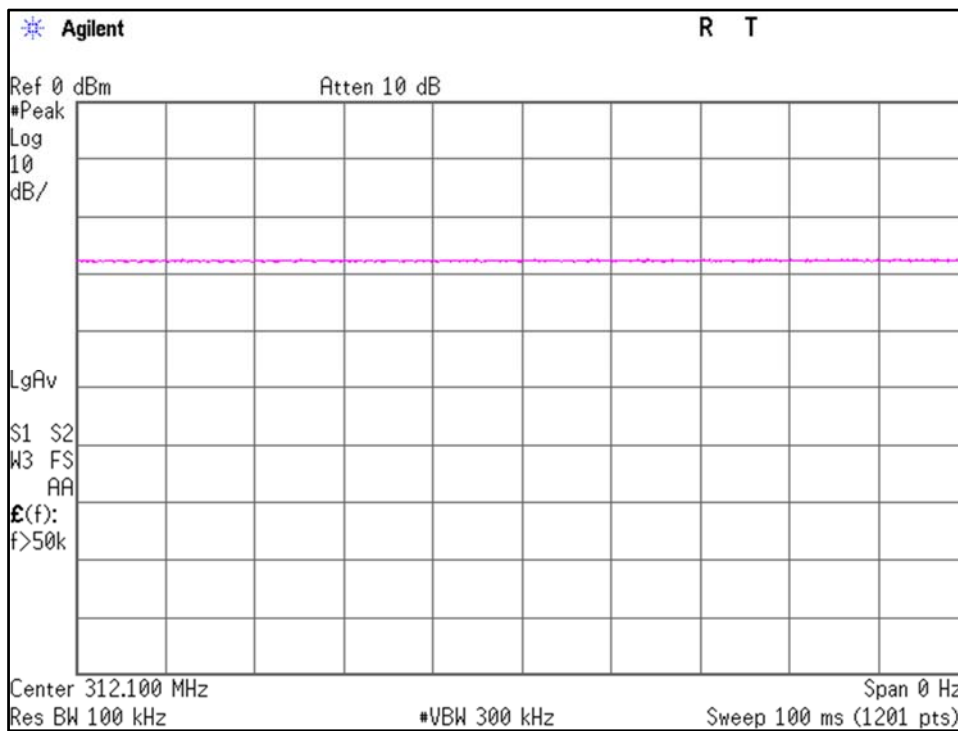
Facsimile : +81 596 24 8124

Duty Cycle

Report No. 13056282H
 Test place Ise EMC Lab.
 Semi Anechoic Chamber No.1
 Date September 27, 2019
 Temperature / Humidity 24 deg. C / 53 % RH
 Engineer Hiroyuki Furutaka
 Mode Transmitting mode 312.10 MHz

ON time [ms]	Cycle [ms]	Duty (On time/Cycle)	Duty [dB]
100.00	100.00	1.00	0.0

ON time = 20log10(ON time/Cycle)

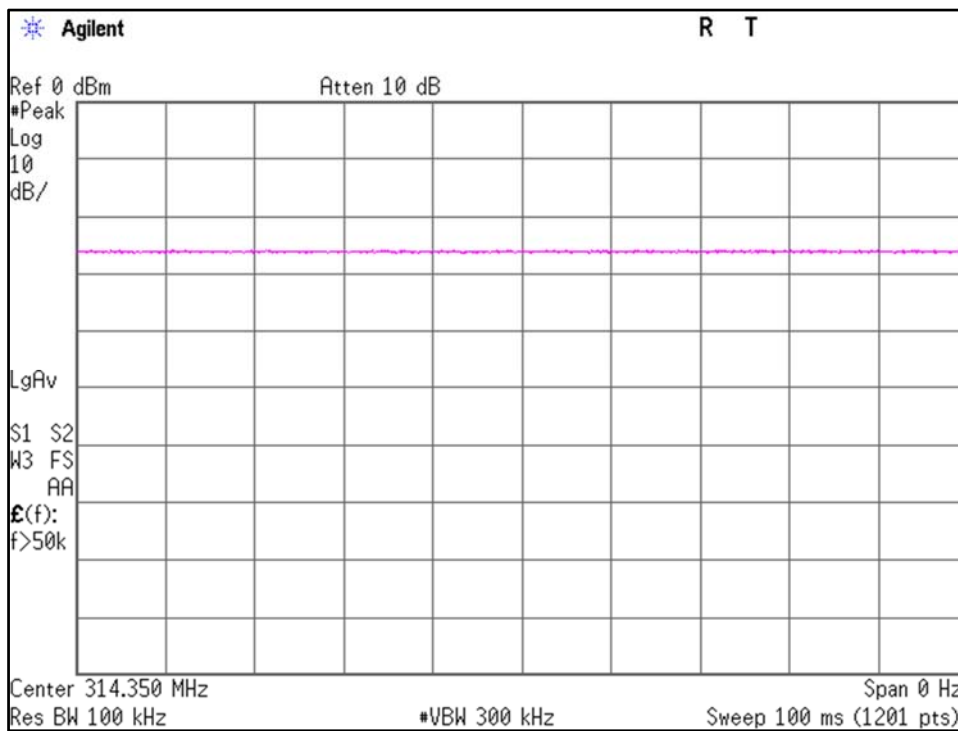


Duty Cycle

Report No. 13056282H
 Test place Ise EMC Lab.
 Semi Anechoic Chamber No.1
 Date September 27, 2019
 Temperature / Humidity 24 deg. C / 53 % RH
 Engineer Hiroyuki Furutaka
 Mode Transmitting mode 314.35 MHz

ON time [ms]	Cycle [ms]	Duty (On time/Cycle)	Duty [dB]
100.00	100.00	1.00	0.0

ON time = 20log10(ON time/Cycle)



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APPENDIX 2: Test instruments

Test Instruments

Test item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
RE	141213	Attenuator(6dB)	Weinschel Corp	2	BK7971	11/05/2018	11/30/2019	12
RE	141198	Biconical Antenna	Schwarzbeck	VHA9103+BBA9106	2513	08/23/2019	08/31/2020	12
RE	141566	Thermo-Hygrometer	CUSTOM	CTH-201	A08Q26	01/11/2019	01/31/2020	12
RE	141998	AC1_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 10m	DA-06881	06/18/2018	06/30/2020	24
RE	141585	Pre Amplifier	MITEQ	MLA-10K01-B01-35	1237616	02/08/2019	02/29/2020	12
RE	142226	Measure	KOMELON	KMC-36	-	-	-	-
RE	141264	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	9111B-189	08/23/2019	08/31/2020	12
RE	141152	EMI measurement program	TSJ	TEPTO-DV	-	-	-	-
RE	141950	EMI Test Receiver	Rohde & Schwarz	ESU26	100412	06/27/2019	06/30/2020	12
RE	141530	Digital Tester	Fluke Corporation	FLUKE 26-3	78030621	08/20/2019	08/31/2020	12
RE	141350	Coaxial Cable	Suhner/storm/Agilent/TSJ	-	-	06/27/2019	06/30/2020	12
RE	142013	AC3_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	04/08/2019	04/30/2021	24
RE	146711	Broad-Band Horn Antenna	Schwarzbeck	BBHA 9120 D	9120D-683	05/17/2019	05/31/2020	12
RE	141297	High Pass Filter(1.1-10GHz)	TOKYO KEIKI	TF219CD1	1001	01/10/2019	01/31/2020	12
RE	141884	Spectrum Analyzer	AGILENT	E4448A	MY44020357	03/13/2019	03/31/2020	12
RE	141554	Thermo-Hygrometer	CUSTOM	CTH-180	1301	01/11/2019	01/31/2020	12
RE	177964	Microwave Cable	Junkosha INC.	MMX221	1901S329(1m)/1902S579(5m)	03/05/2019	03/31/2020	12
RE	141580	MicroWave System Amplifier	AGILENT	83017A	MY39500779	03/05/2019	03/31/2020	12
RE	142183	Measure	KOMELON	KMC-36	-	-	-	-
RE	141532	DIGITAL HITESTER	HIOKI	3805	51201197	01/29/2019	01/31/2020	12
RE	142008	AC3_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	06/26/2018	06/30/2020	24
RE	142645	Loop Antenna	UL Japan	-	-	-	-	-

*Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item:

RE: Radiated emission, 99 % Occupied Bandwidth, -20 dB bandwidth, Automatically deactivate and Duty cycle tests

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